

MOSFET

OptiMOS[™]5 Power-Transistor, 80 V

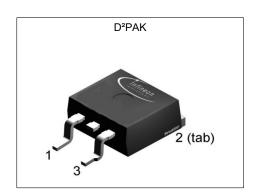
Features

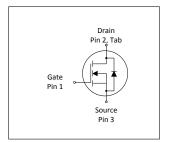
- Ideal for high frequency switching and sync. rec.
 Excellent gate charge x R_{DS(on)} product (FOM)
 Very low on-resistance R_{DS(on)}
 N-channel, normal level

- 100% avalanche tested
- Pb-free plating; RoHS compliant
 Qualified according to JEDEC¹⁾ for target applications
 Halogen-free according to IEC61249-2-21



Parameter	Value	Unit
V _{DS}	80	V
R _{DS(on),max}	1.7	mΩ
I _D	177	A
Q _{oss}	207	nC
Q _G (0V10V)	178	nC











Type / Ordering Code	Package	Marking	Related Links
IPB017N08N5	PG-TO 263-3	017N08N5	-

OptiMOS[™]5 Power-Transistor, 80 V



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OptiMOS[™]5 Power-Transistor, 80 V . IPB017N08N5



1 Maximum ratings at T_A =25 °C, unless otherwise specified

Table 2 **Maximum ratings**

Davamatav	Cumbal	Values			l lmi4	Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Continuous drain current	I _D	-	-	177 136	А	T _C =25 °C T _C =100 °C	
Pulsed drain current ¹⁾	I _{D,pulse}	-	-	708	Α	T _C =25 °C	
Avalanche energy, single pulse ²⁾	E _{AS}	-	-	1228	mJ	$I_{\rm D}$ =100 A, $R_{\rm GS}$ =25 Ω	
Gate source voltage	V _{GS}	-20	-	20	V	-	
Power dissipation	P _{tot}	-	-	375	W	T _C =25 °C	
Operating and storage temperature	T _j , T _{stg}	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56	

2 Thermal characteristics

Table 3 Thermal characteristics

Doromotor	Cumbal	Values			Unit	Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Thermal resistance, junction - case	R _{thJC}	-	0.3	0.4	K/W	-	
Thermal resistance, junction - ambient, minimal footprint	R _{thJA}	-	-	62	K/W	-	
Thermal resistance, junction - ambient, 6 cm² cooling area³)	R _{thJA}	-	-	40	K/W	-	
Soldering temperature, wave and reflow soldering are allowed	T _{sold}	-	-	260	°C	Reflow MSL1	

See Diagram 3 for more detailed information
 See Diagram 13 for more detailed information
 Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.



3 Electrical characteristics

Table 4 Static characteristics

Barranatan	0	Values					
Parameter	Symbol	Min.	Min. Typ. I		Unit	Note / Test Condition	
Drain-source breakdown voltage	V _{(BR)DSS}	80	-	-	V	V _{GS} =0 V, I _D =1 mA	
Gate threshold voltage	V _{GS(th)}	2.2	3	3.8	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 280 \ \mu {\rm A}$	
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μA	V _{DS} =80 V, V _{GS} =0 V, T _j =25 °C V _{DS} =80 V, V _{GS} =0 V, T _j =125 °C	
Gate-source leakage current	I _{GSS}	-	1	100	nA	V _{GS} =20 V, V _{DS} =0 V	
Drain-source on-state resistance	R _{DS(on)}	-	1.5 1.8	1.7 2.1	mΩ	V _{GS} =10 V, I _D =100 A V _{GS} =6 V, I _D =50 A	
Gate resistance ¹⁾	R _G	-	1.5	2.3	Ω	-	
Transconductance	g_{fs}	114	228	-	S	$ V_{DS} > 2 I_D R_{DS(on)max}, I_D = 100 A$	

Table 5 Dynamic characteristics¹⁾

Davamatav	Syran had		Values				
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance	C _{iss}	-	13000	16900	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz	
Output capacitance	Coss	-	2000	2600	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz	
Reverse transfer capacitance	C _{rss}	-	86	150	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz	
Turn-on delay time	$t_{ m d(on)}$	-	40	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 Ω	
Rise time	t _r	-	36	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 Ω	
Turn-off delay time	$t_{ m d(off)}$	-	102	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 Ω	
Fall time	t _f	-	37	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 Ω	

Table 6 Gate charge characteristics²⁾

Parameter	Cumbal	Values			I Imi4	Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Gate to source charge	Q _{gs}	-	57	-	nC	V _{DD} =40 V, I _D =100 A, V _{GS} =0 to 10 V	
Gate to drain charge ¹⁾	Q _{gd}	-	37	56	nC	V _{DD} =40 V, I _D =100 A, V _{GS} =0 to 10 V	
Switching charge	Q _{sw}	-	59	-	nC	V _{DD} =40 V, I _D =100 A, V _{GS} =0 to 10 V	
Gate charge total	Qg	-	178	223	nC	V_{DD} =40 V, I_{D} =100 A, V_{GS} =0 to 10 V	
Gate plateau voltage	V _{plateau}	-	4.5	-	V	V_{DD} =40 V, I_{D} =100 A, V_{GS} =0 to 10 V	
Gate charge total, sync. FET	Q _{g(sync)}	-	153	-	nC	V _{DS} =0.1 V, V _{GS} =0 to 10 V	
Output charge ¹⁾	Qoss	-	207	275	nC	V _{DD} =40 V, V _{GS} =0 V	

 $^{^{1)}}$ Defined by design. Not subject to production test $^{2)}$ See "Gate charge waveforms" for parameter definition

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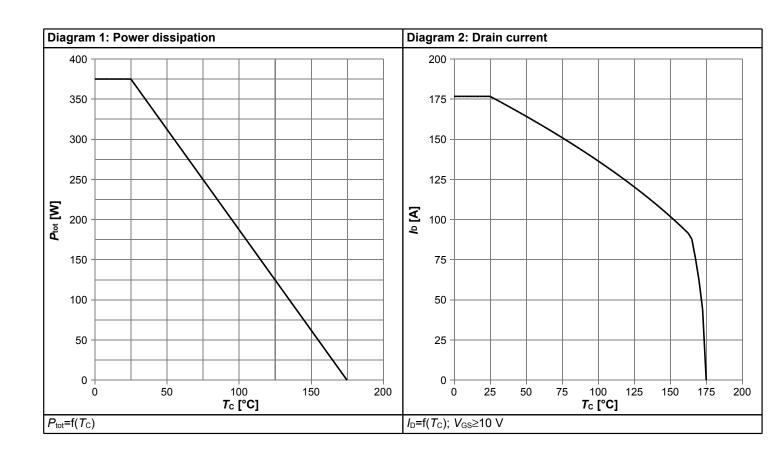


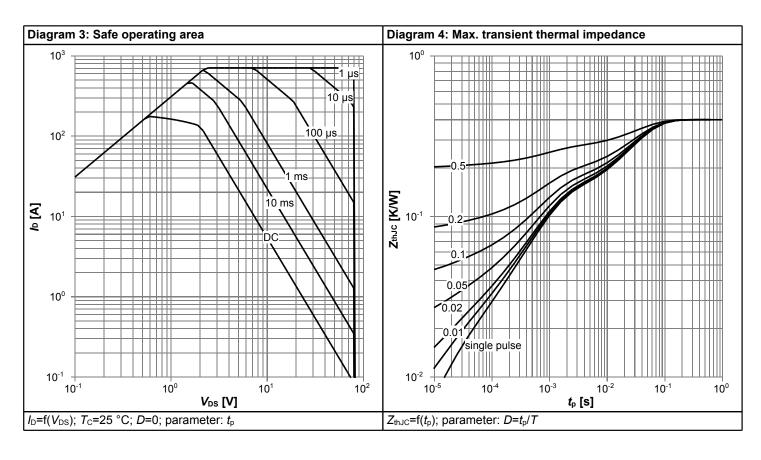
Table 7 Reverse diode

Davometer	Cumbal		Values			Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Diode continous forward current	Is	-	-	152	Α	<i>T</i> _C =25 °C	
Diode pulse current	I _{S,pulse}	-	-	708	Α	<i>T</i> _C =25 °C	
Diode forward voltage	V _{SD}	-	0.89	1.2	V	V _{GS} =0 V, I _F =100 A, T _j =25 °C	
Reverse recovery time ¹⁾	t _{rr}	-	105	210	ns	V_R =40 V, I_F =100 A, di_F/dt =100 A/ μ s	
Reverse recovery charge ¹⁾	Qrr	-	308	616	nC	V _R =40 V, I _F =100 A, di _F /dt=100 A/μs	

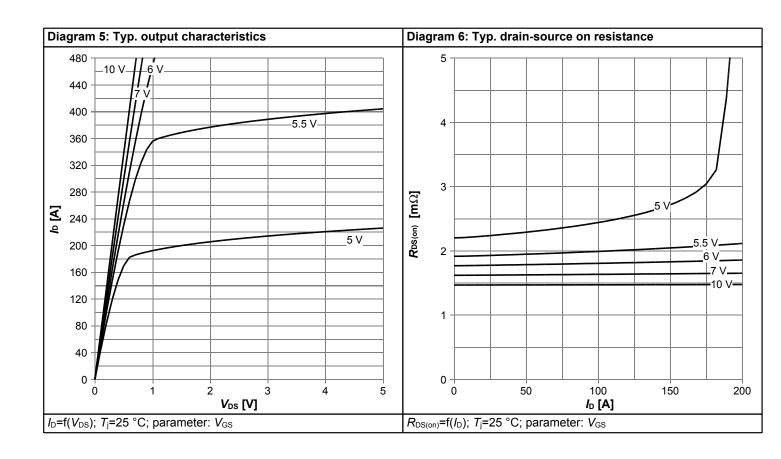


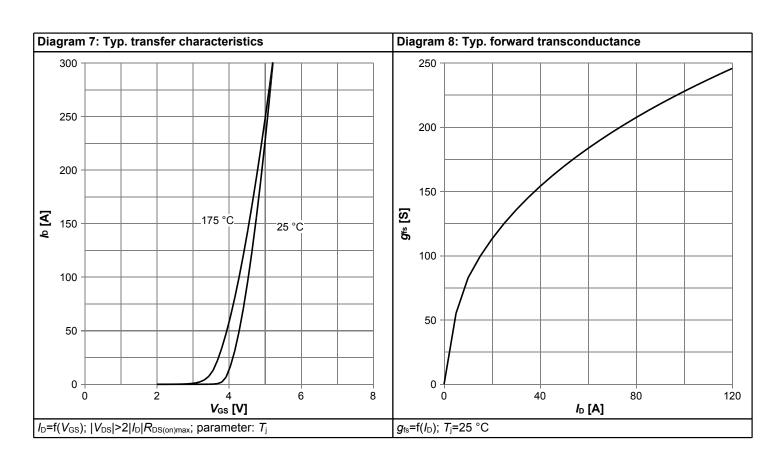
4 Electrical characteristics diagrams



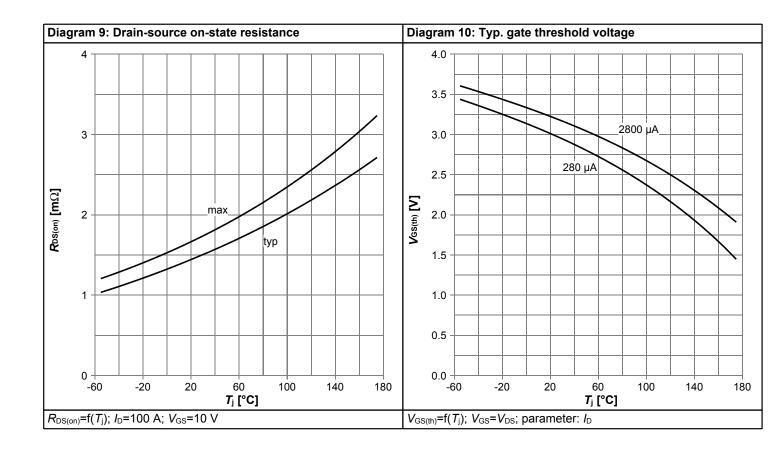


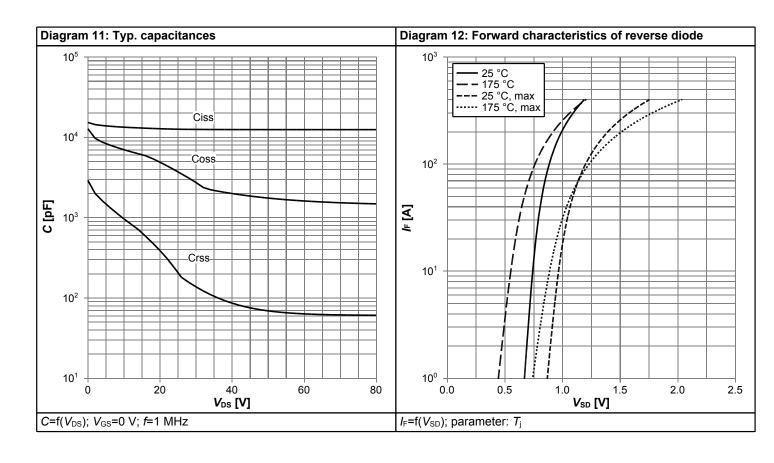




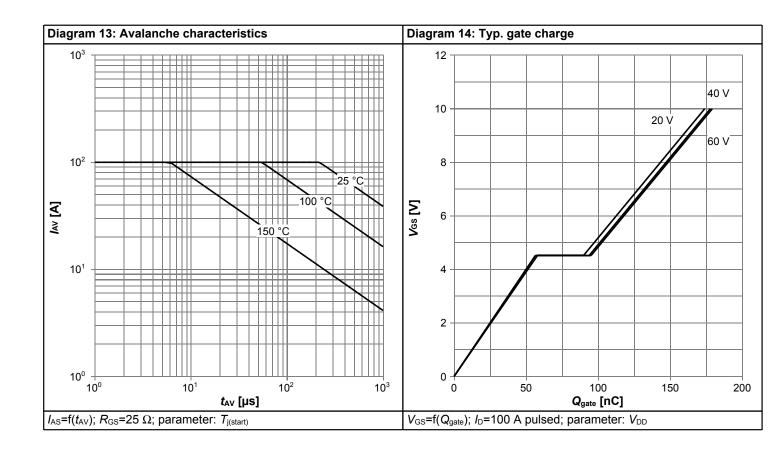


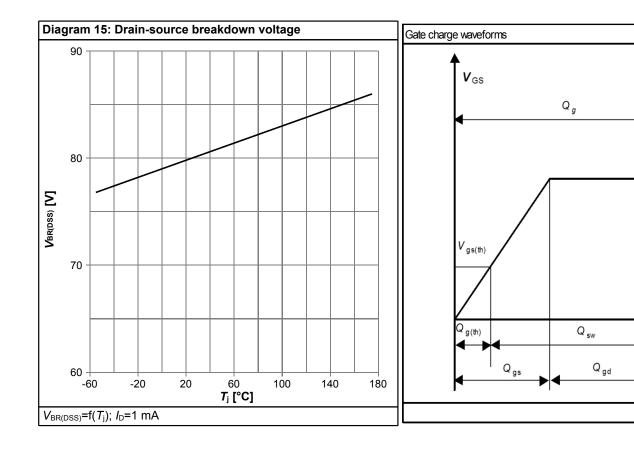






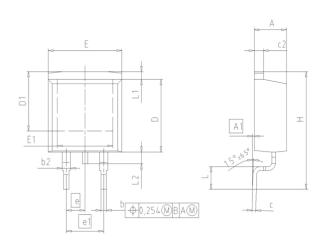


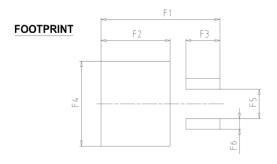






5 Package Outlines





DIM	MILLIN	METERS	INCI	HES			
DIM	MIN	MAX	MIN	MAX			
Α	4.30	4.57	0.169	0.180			
A1	0.00	0.25	0.000	0.010			
b	0.65	0.85	0.026	0.033			
b2	0.95	1.15	0.037	0.045			
С	0.33	0.65	0.013	0.026			
c2	1.17	1.40	0.046	0.055			
D	8.51	9.45	0.335	0.372			
D1	7.10	7.90	0.280	0.311			
E	9.80	10.31	0.386	0.406			
E1	6.50	8.60	0.256	0.339			
е	2.	2.54		0.100			
e1	5.	08	0.200				
N		2	2				
Н	14.61	15.88	0.575	0.625			
L	2.29	3.00	0.090	0.118			
L1	0.70	1.60	0.028	0.063			
L2	1.00	1.78	0.039	0.070			
F1	16.05	16.25	0.632	0.640			
F2	9.30	9.50	0.366	0.374			
F3	4.50	4.70	0.177	0.185			
F4	10.70	10.90	0.421	0.429			
F5	3.65	3.85	0.144	0.152			
F6	1.25	1.45	0.049	0.057			

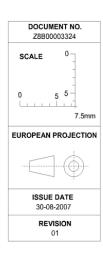


Figure 1 Outline PG-TO 263-3, dimensions in mm/inches

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Revision History

IPB017N08N5

Revision: 2017-07-11, Rev. 2.2

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.1	2014-05-05	Release of Final Version
2.2	2017-07-11	Update product current

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